Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/516,690	SHIMOE ET AL.	
Examiner	Art Unit	
Jeff Natalini	2858	

	SEARCHED					
Class	Subclass	Date	Examiner			
32Y	622	11/23/05	Sy			
324	76.13	11/23/05	Sn			
324	76.12	11/23/05	9h			
324	76,52	(1/23/05	Th			
324	76.53	11/23/05	R			
324	37	11/23/05	W			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
324	76.13	11/23/08	Sm	
324	76.53	11/23/05	Zu	
324	34	11/23/05	Zu	
, clon sewoh		11/25/05	gu	

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
East eauther search eassignee search text search	11/22/05	Zn			
East 327/622 324/76,13 324/76,52 324/76,53	11/23	M			
34/71.12p/Lext and text search 327/37	11/23	Sm			
Consult w/ Examiler Anjan Deb about Claims, seach, patentability	11/23	m			
1324/76,77,86,771 433 WHEXT IEEE Seach	11/25	Sn			
Interference .clm Senrch	11/25	Zn			